Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,567	MIURA ET AL.
Examiner	Art Unit
Monica Lewis	2822

SEARCHED					
Class	Subclass	Date	Examiner		
257	666,675, 712,796	3/23/2007	ML		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interferen	ce Search	3/23/2007	ML ·	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EIC Search	3/23/2007	ML	
East Search	3/23/2007	ML	
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